Nano Sensors

PhD/ MTech/ BTech Course No.: EEL7450 L-T-P [C]: 3-0-0 [3] Prof. AJAY AGARWAL

ELECTRICAL ENGINEERING

IIT JODHPUR

Lecture 34-35 dated 15th Apr 2025

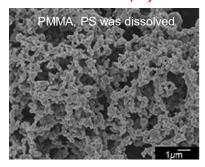
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Lithography using self assembly:

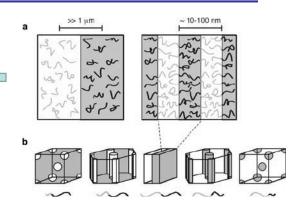
- block co-polymer self assembly,
- porous anodized aluminum oxide and
- nano-sphere lithography
- 1. Di-block copolymer self assembly overview.
- 2. Guided (directed, aligned) self assembly.
- 3. Block copolymer lithography.
- 4. Anodized aluminum oxide (AAO) overview.
- 5. Nanofabricating using AAO template
- These are three most important self-assembly techniques, widely used for nanofabrication, with numerous publications each year.
- Basically, for those who don't have access or don't like too much EBL, FIB or imprint, they can often use self-assembly fabrication to demonstrate their idea.
- The most significant advantage of self-assembly is low cost.
- The biggest limit: only periodic pattern can be created, usually without long range ordering.

Phase separation of block copolymers

Phase separation of a blend of PMMA and PS homo-polymer



- 1. A mixture of PMMA (M_w=93.9 kg/mol) and polystyrene (PS, M_w=194.9 kg/mol) (PS/PMMA=70/30, w/w) is dissolved in tetrahydrofuran (THF) to form a 5 wt% solution.
- 2. Polymer film was made by spin-cast the solution on glass slide.
- 3. Exposure to cyclohexane at 70°C to dissolve PS.

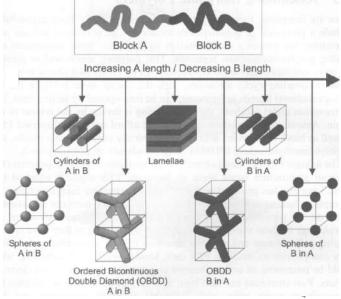


- a) A blend of two incompatible homo-polymer separates into distinct phases on a large scale (left), whereas block copolymers microphase separate into periodic domains (right).
- b) Basic morphologies obtained by different block copolymer compositions.

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Typical self assembly behavior for linear block copolymers



"Nanochemistry: a chemical approach to nanomaterials" by Ozin

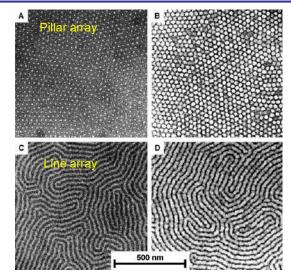
Typical self assembly behavior for linear block copolymers

Nature of patterns	Spheres (SPH) (3D)	Cylinders (CYL) (2D)	Double gyroid (DG) (3D)	Double diamond (DD) (3D)	Lamellae (LAM) (1D)
Space group	lm3m	p6mm	Ia3̄d	Pn3m	pm
Blue domains: A block					
Volume fraction of A block	0-21%	21-33%	33	3-37%	37-50%

- Block copolymer self-assembly study is started in the bulk phase, as shown above; whereas thin film is desired for nanofabrication and device application.
- When film thickness is well controlled, hole/ pillar array or line arrayspattern can be created.

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One example: self-assembly of PS-PB di-block copolymer



PS: polystyrene PB: polybutadiene

1,3-butadiene

The most attractive feature of block copolymer self assembly is the extremely high resolution, easily get features down to 10nm.

TEM images of PS-PB diblock copolymer film masks (a, c) and lithographically patterned silicon nitride (b, d).

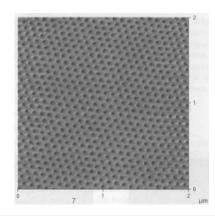
C. Harrison, Science

Block copolymer thin films

- Film applied by drop casting, dip coating, and spin coating.
- Film is then treated to increase the degree of ordering.
- Such as annealing above the order-disorder transition temperature for several days.
- Or annealing in the presence of solvent vapor (toluene...) to swell the film and make the polymer more mobile.
- One way to achieve alignment is through directional solidification strategy
- Such as using a temperature gradient the film is heated to above order-disorder transition and cooled in the presence of such gradient; so that the ordered phase nucleates at the cool end that serves as a template and orient the rest of the film.
- Annealing film in the presence of a gradient in solvent vapor has similar effect.

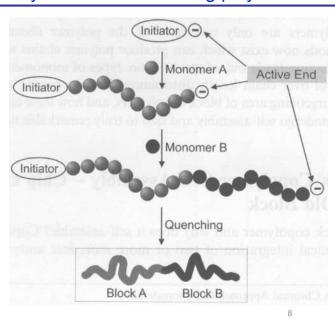
Film ordered by controlled solvent evaporation.

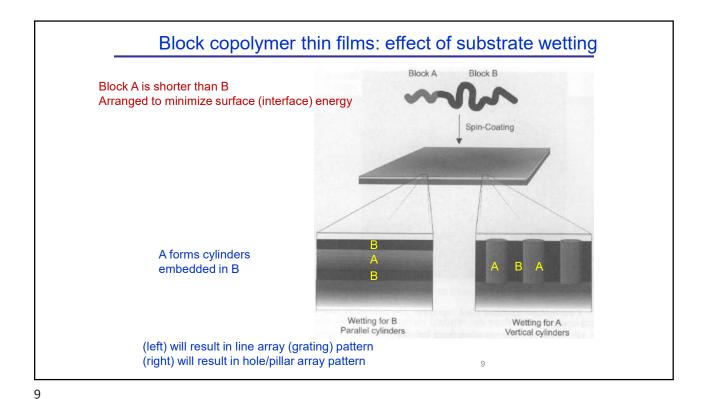
Advanced Material, 16, 226 (2004)



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Synthesis: anionic living polymerization





Lithography using self assembly: block co-polymer self assembly, porous anodized aluminum oxide and nano-sphere lithography

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Guided block copolymer self assembly for long range ordering and periodicity

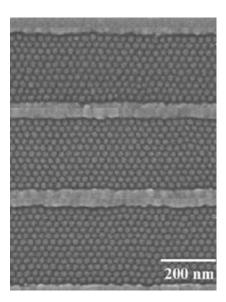
Micro-phase separated block copolymer can be directed/aligned by:

- Electric field
- Shearing force
- Surface control of wettability
- Chemical pattern on surface
- Nano-structured surface
- Spatial confinement by surface relief pattern in substrate and mold
- Void in a range of porous host

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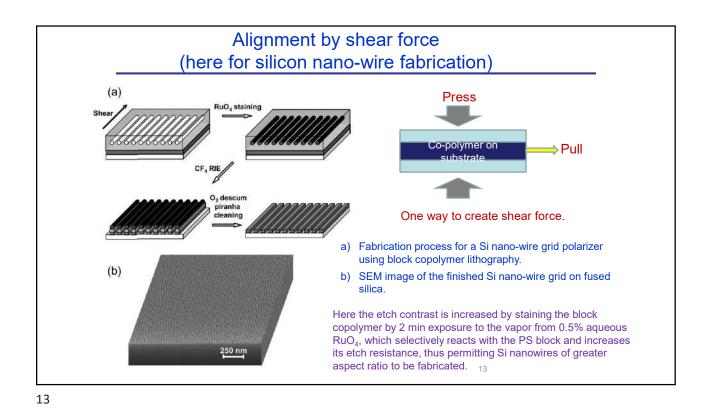
Alignment by pre-patterning the substrate



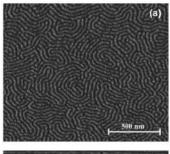
Spherical domains assembled from PS–PFS (polystyrene-polyferrocenyldimethylsilane) block copolymer inside patterned SiO₂ grooves.

The 1.5 wt.% PS-PFS block copolymer in toluene solution was spin-coated onto the grooved substrate and then annealed at 140°C for 48h to obtain a monolayer of spherical PFS domains in a PS matrix within the substrate grooves.

Ross, "Templated self-assembly of block copolymers: effect of substrate topography", Adv. Mater. 15, 1599–1602 (2003).



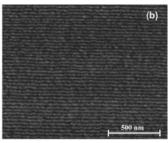
Alignment by shear force (for silicon nano-wire fabrication)



Tapping mode AFM <code>phase</code> images of PS–PHMA thin films on top of an $\alpha\textsc{-Si}$ layer on a fused silica substrate:

- a) Quiescently annealed
- b) Shear aligned.

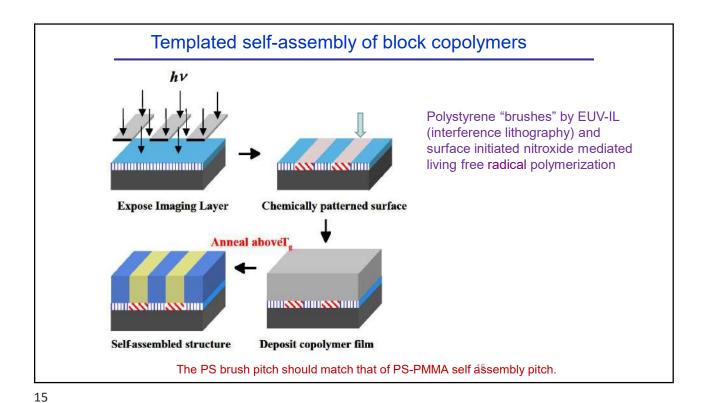
Glassy (hard) PS cylinders are shown as light in a dark rubbery (soft) PHMA matrix.



Polystyrene-b-poly(n-hexyl methacrylate) (PS–PHMA) diblock copolymer with a molar mass of 21 and 64 kg/mol for the respective blocks.

Pitch=30nm

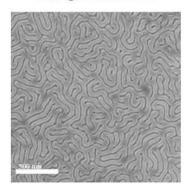
Chaikin, "Silicon nanowire grid polarizer for very deep ultraviolet fabricated from a shear-aligned diblock copolymer template", Optics letters, 32(21), $\frac{3}{4}$ 25-3127 (2007).



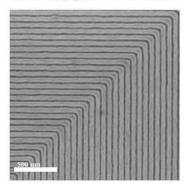
Polymerization of block-copolymers on chemically pre-patterned substrates Polystyrene-block-methyl meth acrylate (PS-b-PMMA), $L_0 = 48$ nm unpatterned substrate area Thermodynamics dominates interface widths and domain sizes. When L_s=47.5nm≈L_o=48nm, block copolymer is almost defect free. patterned Here chemically patterned substr. area grating with polystyrene "brush" $L_s = 50 \text{ nm}$ $L_s = 45 \text{ nm}$ $L_s = 47.5 \text{ nm}$ $L_s = 52.5 \text{ nm}$ P. F. Nealey, H. H. Solak et al. Nature 424 (2003)

Directed assembly of block copolymer blends into non-regular device oriented structure

Homogeneous Surface



Directed assembly on chemically patterned surface



Block copolymer materials that naturally form simple periodic structures were directed to assemble into non-regular device oriented patterns (here an elbow) on chemically nano-patterned substrates.

Mark P. Stoykovich, Marcus Müller, Sang Ouk Kim, Harun H. Solak, Paul F. Nealey, Science, 308, 144271446 (2005).

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Directed assembly of nanoparticle filled block copolymer $L_s \approx L_{NC} + 5\%$ Fabrication Process Chemically patterned substrate Spin coating of lock copolymer/nanoparticle Thermal annealing Removal of polymers using oxygen plasma PMMA Bulk Lamellar Period: 49 nm PS-b-PMMA: 104K, PS: 45K, PMMA: 46K ϕ_{H} homopolymer volume fraction respect to total polymers in blends $\begin{array}{c|ccccc} L_S > L_{NC} & L_S > L_{NC/9} \\ \hline \text{w/o homopolymer} & \text{w/homopolymer} \\ \hline \text{Oboxastakis et al., } JCP \ 2004 \\ \hline \text{Hierarchical assembly of nanoparticles using directed assembly} \end{array}$: Lamellar periodicity of nanocomposite Cadmium Selenide (CdSe) of block copolymer on chemically patterned substrate. capped with tetradecyl-· Homopolymer addition in block copolymer/nanoparticle system phosphonic acid (TDPA) $(8.0 \pm 0.4 \text{ nm})$ mitigates particle aggregation for the extended block copolymer chain conformation regime.

Alignment by electric field

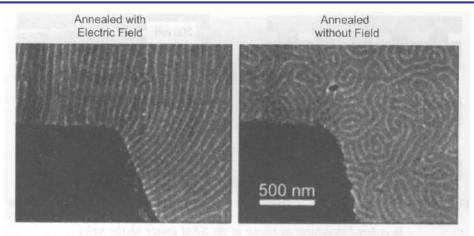


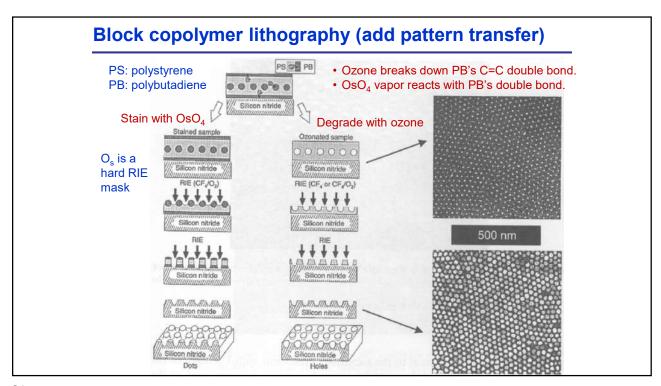
Figure 9.7 TEM micrographs of block copolymer films annealed in the presence of an electric field and without a field, highlighting the electric field alignment near the electrode seen in the bottom left parts of the images.

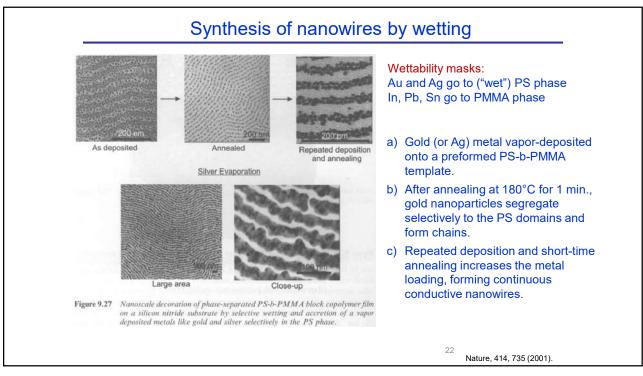
"Local control of microdomain orientation in diblock copolymer thin films with electric fields", Science, 273, 931 (1996)

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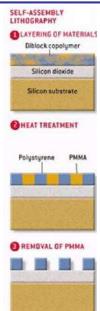
Lithography using self assembly: block co-polymer self assembly, porous anodized aluminum oxide and nanosphere lithography

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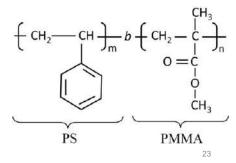






- After deep UV-exposure, polymer chain of PMMA is cut (PMMA is a positive deep UV lithography resist), making it more soluble in solvent.
- 2. Whereas the polystyrene (PS) chain is cross-linked, making it hard to dissolve by solvent.
- 3. Therefore, PMMA can be selectively removed by solvents like acetic acid afterwards.

(PMMA chain can also be broken by UV light at λ =365nm, but need very long time exposure, ~1 h at 40mW/cm² intensity)



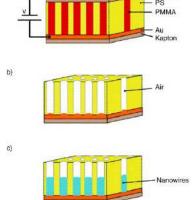
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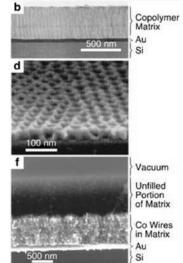
Nanofabrication of vertical nanowires by electroplating

Kapton

Electric field is for vertical alignment of self-assembly

- Aligned by electric field during annealing.
- PS 71%, to obtain 14nm PMMA cylinder.
- Deep UV simultaneously degrades PMMA & cross-link PS.
- Acetic acid dissolve PMMA but not cross-linked PS (polystyrene).
- Methanol is added to aqueous plating solution to better wet hydrophobic PS membrane.

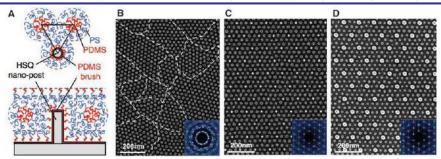




Science, 290, 2126 (2000)

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Density multiplication (here by 9x) lithography



- A. Top-down and side-view schematics showing the arrangement of PS-b-PDMS block copolymer molecules in the region surrounding a single post made from cross-linked HSQ resist (by e-beam lithography). The post and substrate surfaces have been chemically functionalized by a monolayer of short-chain PDMS brush.
- B. A poorly ordered monolayer of BCP (block co-polymer) spherical domains formed on a flat surface (without template guidance). The boundaries between different grain orientations are indicated with dashed lines. The inset is a 2D Fourier transform of the domain positions that shows the absence of long-range order.

C-D. SEM images of ordered BCP spheres formed within a sparse 2D lattice of HSQ

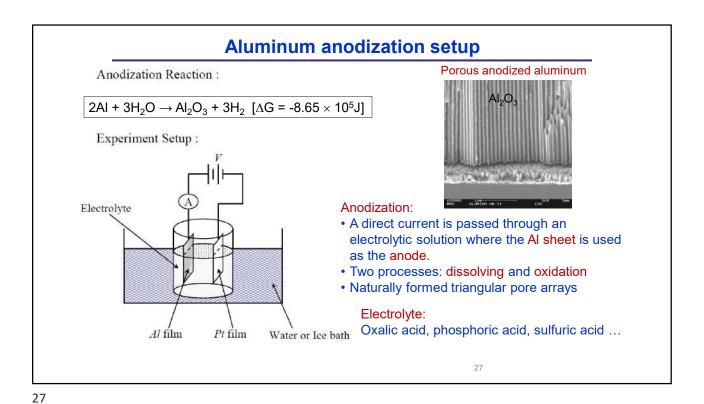
For the moment, this is considered as the most promising route for bit-patterned magnetic recording media fabrication (make the mold for nanoimprint lithography), up to 10Tbits/in² for pitch ~8nm.

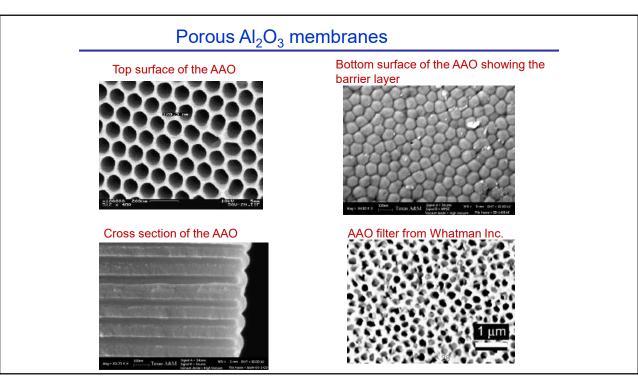
Ross, "Graphoepitaxy of self-assembled block copolymers on two-dimensional periodic patterned templates", Science, 321, 939-943 (2008).

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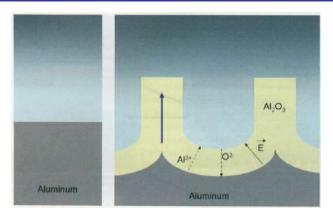
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Nano-pore formation mechanism

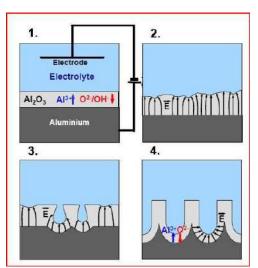


- Two types of electrical current due to 1) oxide growth, 2) its dissolution.
- The barrier has to be thin to be "transparent" for anions OH- and O2-.
- These ions interacts with Al3+ ions, which can also move under electric field.
- The wall is "pushed" upward by the continuous anodization at the oxide/Al interface.
- Other mechanisms have also been reported.

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Nano-pore formation mechanism

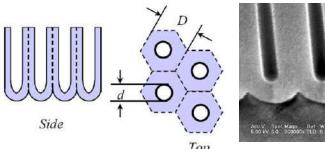


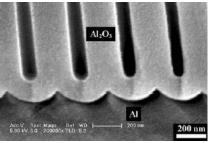
Schematic diagram of the pore formation at the beginning of the anodization.

- 1. Formation of barrier oxide on the entire area.
- 2. Local field distributions caused by surface fluctuations.
- Creation of pores by field-enhanced or/and temperature-enhanced dissolution. Some pores stop growing due to competition among pores.
- 4. Stable pore growth.

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Pore dimensions





Controlling parameters: voltage, electrolyte, temperature and time. Cell size D \sim 2.5×V (nm), V is voltage with a unit volt. Pore size d \sim V (nm), depends on pH; but pore can be enlarged in acids.

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Common acids for AAO

Table 1. Lists the array of geometrical parameters as a function of the anodization conditions.

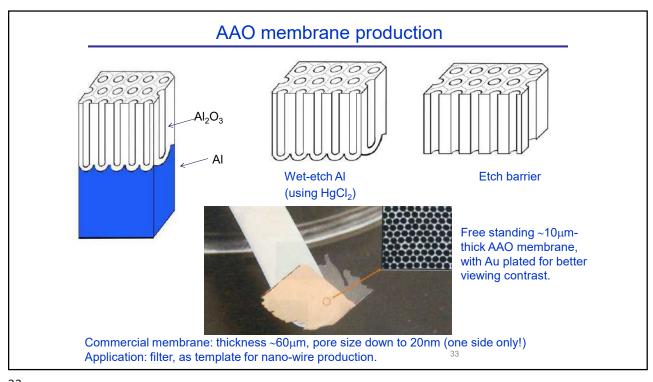
Electrolyte	Interpore Distance, D_{int}	Inner Wall Thickness, D _{inner}	Pore Diameter, D _P	Porosity
H ₂ SO ₄ 25 V 0.3 M	66.3 nm	7.2 nm	24 nm	12%
(COOH) ₂ 40 V 0.3 M	105 nm	9.1 nm	31 nm	8%
H ₃ PO ₄ 195 V 0.1 M	501 nm	54 nm	$458.4\mathrm{nm}$	9%



Oxalic acid

- Sulfuric acid generally gives smallest pore diameter and largest pore density.
- Standard deviation of pore diameter usually is within 10%.

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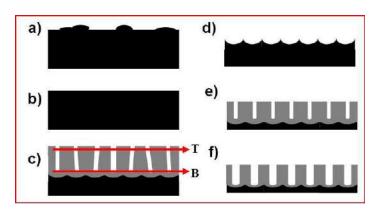
Chemistry involved in nanofabrication using AAO

- Removing AI without attacking AAO: saturated HgCl₂
 AI + HgCl₂-----AI³⁺ + Hg, room temperature
- Removing AAO without attacking AI: It is not easy for AI to dissolve in H2CrO4 aqueous.
 6%H₃PO₄ + 1.8%H₂CrO₄, 60°C, 2h
- Removing the barrier layer at the bottom without attacking too much the AAO pores.
 5%H₃PO₄, 30°C, 30min

Two-step anodization process to improve periodicity

Stages of the formation of selfordered alumina:

- a) Annealing at 500°C for 3h to increase grain size;
- b) electro-polishing in a solution of 1/4 HClO₄ + 3/4 C₂H₅OH for 4 min at 8V with agitation;
- c) first anodization;
- d) selective dissolution of the formed oxide layer;
- e) second anodization under the same conditions as the first anodization; and
- f) if needed, isotropic etching in 1M phosphoric acid at 30°C to widen the pores.



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Pre-pattern Al surface can also improves periodicity

Al is pre-patterned by FIB

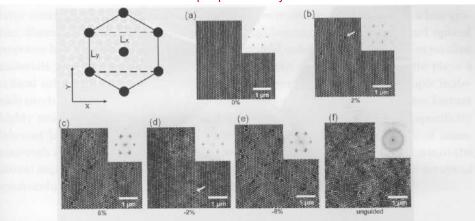
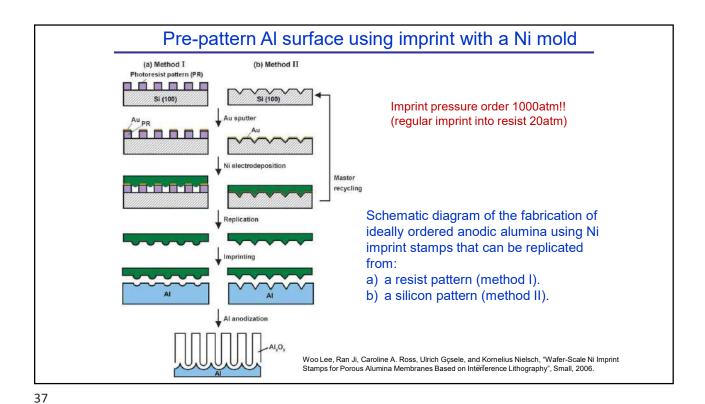
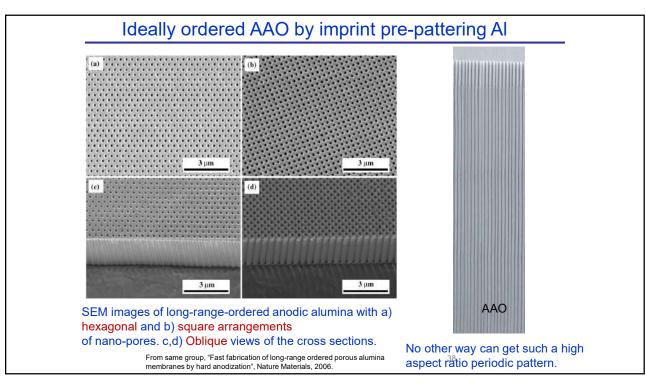


Figure 3. Diagram of an unit cell of the lattice followed by AFM images of the barrier with lattice mismatch = (a) 0%, (b) 2%, (c) 6%, (d) -2%, (e) -8% and (f) a self-organized structure with insets showing the 2D power spectra of the corresponding regions of the 10 micron AAO films. White arrows in (b) and (d) indicate point defects in the lattice. [Reproduced with permission from APL 84, No 14 (2004) Pg 2510.] "Order-disorder transition of anodic alumina nanochannel arrays grown

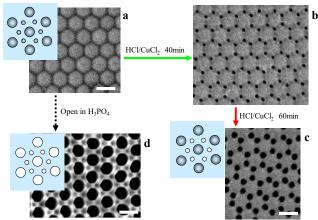
under the guidance of focused-ion-beam patterning", page 2509-2511.





Novel structure of AAO film

Anodization using 0.8 M $H_2SO_4 + 0.1$ M $Al_2(SO_4)_3$ solution. Addition of $Al_2(SO_4)_3$ allows higher current density/voltage, which leads to this new structure. A discovery by "accident".



SEM of AAO with novel structure. (a) View of bottom, just removing the AI substrate in a mixed solution of $HCI/CuCl_2$ (immersing for 20min); (b) extending the immersing time till 40 min, small pores appear; (c) extending the immersing time till 60 min; (d) after immersing in 5% H_3PO_4 , the normal nano-pores are opened, surrounded by six small pores. The scale bar is 100nm.

Shiyong Zhao, Arthur Yelon and Teodor Veres. "Novel structure of AAO film fabricated by constant current anodization" Adv. Mater. 19(19), 3004, 2007.

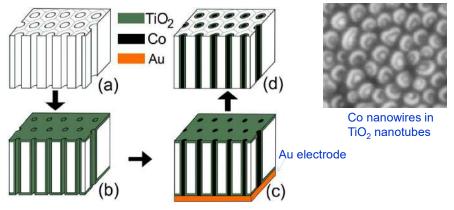
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Shrink pore diameter by isotropic coating onto AAO

- The pore spacing and the pore diameter are coupled to each other and determined by the applied voltage of anodization.
- Pores are easy to enlarge using subsequent wet etching after anodization.
- It is more challenging to shrink the pore size.

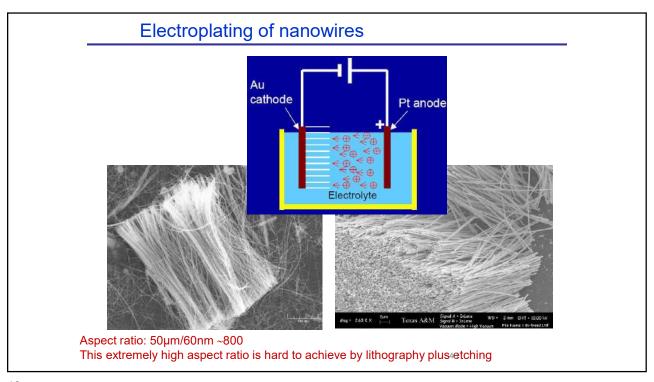


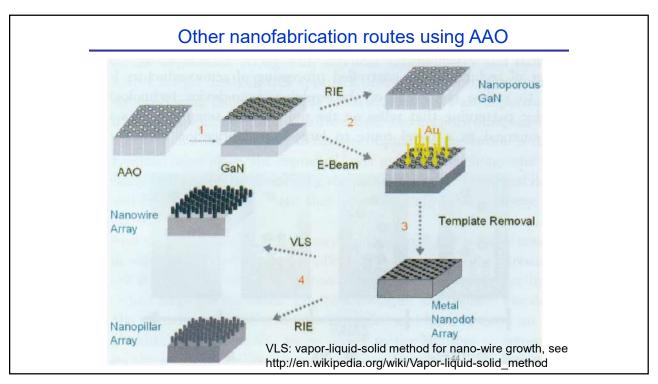
TiO₂ is coated by isotropic sol–gel deposition technique

Z. Ye, H. Liu, I. Schultz, W. Wu, D. G Naugleand I. Lyuksyutov, Nanotechnology 19, 325303 (2008).

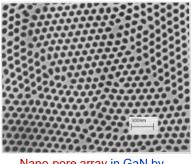
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Deposition of TiO_2 nanotubes using Sol-Gel method $TiO_2 \text{ nanotubes after dissolving AAO}$ AAO coated with TiO_2 Cross section of TiO_2 nanotubes $TiO_2 \text{ nanotubes after dissolving AAO}$ $TiO_2 \text{ nanotubes after dissolving AAO}$

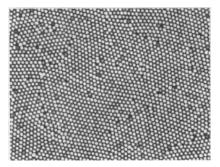




Patterning GaN using AAO



Nano-pore array in GaN by RIE using AAO as mask



Nano-pillar array in GaN by metal liftoff using AAO, followed by GaN RIE.

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Grow carbon nanotube into AAO pores

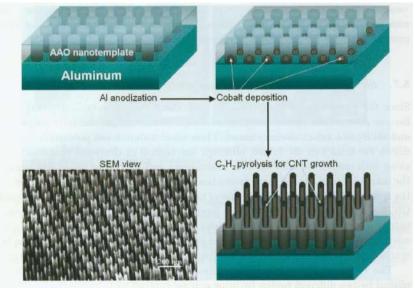
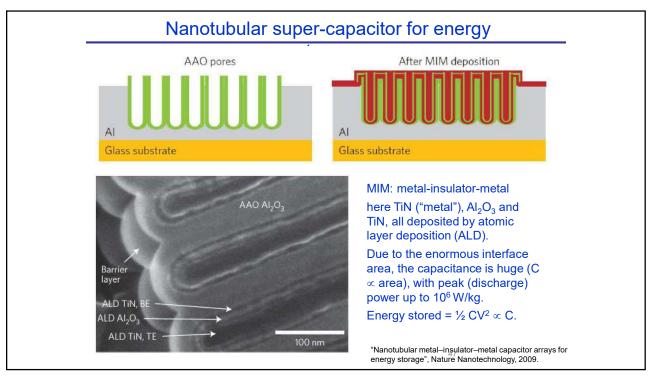
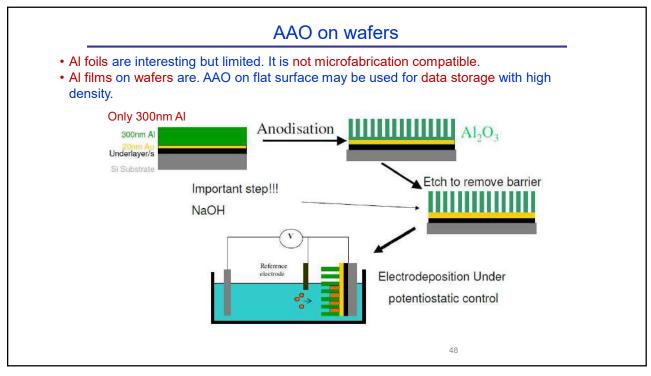
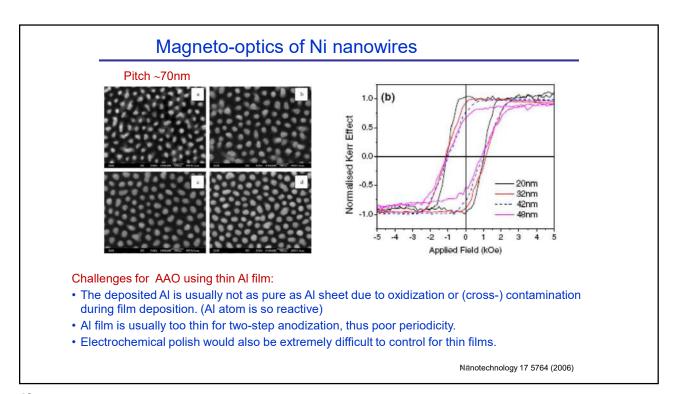
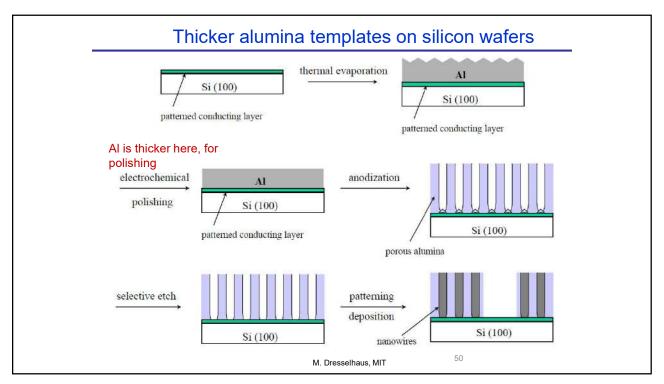


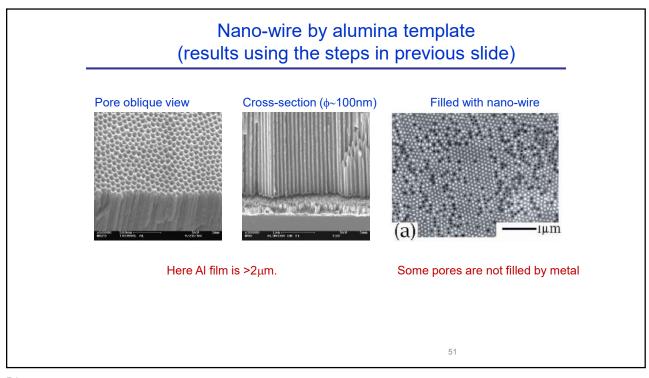
Figure 17. Schematics of catalyst-assisted CNT growth in AAO templates. Below, left a top view SEM image of CNT array is presented. Reprinted with the permission of [68 Papadopoulos, A. Rakitin, J. Li, A. S. Vedeneev, and J. M. Xu, Phys. Rev. Lett. 85, 3476-3479 (2000)].











End of AAO based nano-patterning